

# EMC TEST REPORT

According to

EN 55022:1998 : EN 61000-3-2:1995+A1: 1998+A2: 1998  
 EN 61000-3-3:1995  
 EN 50130-4:1995+A1:1998 : EN 61000-4-2:1995+A1:1998  
 EN 61000-4-3 / EN 61000-4-4  
 EN 61000-4-5 / ENV 50141 / EN 61000-4-11  
 Main Supply Voltage Variations

EQUIPMENT : PHOTOELECTRIC BEAM SENSOR

MODEL NO. : PB-80HD, PB-60HD, PB-30HD

APPLICANT : YUAN HSUN ELECTRIC CO., LTD.

NO. 57, CHUNG-HE RD., KAOHSIUMG CITY, TAIWAN,  
 R. O. C.

Test Engineer : JOHSONG CHANG

Checked by : JASON GONG

Issued Date : APR. 09, 2002

The test report shall not be reproduced except in full, without the written approval of the laboratory.

The report can't be used by the client to claim product endorsement by PEP Testing Laboratory.

This report is only for the equipment which described in page 7.

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# 1. General

## 1.1 General Information :

Applicant : YUAN HSUN ELECTRIC CO., LTD.  
 NO. 57, CHUNG-HE RD., KAOHSIUNG CITY, TAIWAN,  
 R. O. C.

Manufacturer : YUAN HSUN ELECTRIC CO., LTD.  
 NO. 57, CHUNG-HE RD., KAOHSIUNG CITY, TAIWAN,  
 R. O. C.

Measurement Procedure : EN 55022 & EN 50130-4

Measurement Uncertainty :

The uncertainty of the testing result is given as below . The method of uncertainty Calculation is provided in PEP Testing Lab. document No. PEPD-15 .

Frequency ( MHz )	0.15 30	30 1000
Combined Uncertainty $\mu_c$	1.77 (dB)	2.08 (dB)

## 1.2 Place of Measurement

### **PEP TESTING LABORATORY**

*12-3Fl, No. 27-1, Lane 169, Kang-Ning St., Hsi-Chin.  
 Taipei Hsien, Taiwan, R. O. C.  
 TEL : 8862-26922097 FAX : 8862-26956236*

NVLAP LAB CODE 200097-0  
 FCC Registration No. : 90868  
 Nemko Aut. No. : ELA133  
 BSMI Aut. No. : SL2-IN-E-11,SL2-A1-E-11  
 VCCI Registration No. : C-493/R-477

## 1.3 Test standard

Tested for compliance with :

- EN 55022:1998** - Information Technology Equipment – Radio disturbance characteristics - Limits and methods of measurement
- EN 61000-3-2:1995 +A1: 1998+A2: 1998** - Electromagnetic compatibility (EMC) Part 3-2: Limits – Limits for harmonic current emissions (equipment input Current up to and including 16A per phase
- EN 61000-3-3:1995** - Electromagnetic compatibility (EMC) Part 3-2: Limits – Limitation of voltage fluctuations and flicker in low-voltage supply systems for equipment with rated current up to 16A

- EN 50130-4:1995+A1: 1998** - Alarm systems – Part 4. Electromagnetic compatibility  
Product family standard: Immunity requirements  
for components of fire, intruder and social alarm systems
- EN 61000-4-2:1995+A1: 1998** - Electromagnetic compatibility (EMC) Part 4: Testing and  
measurement techniques, Section 2: Electrostatic discharge  
immunity test Basic EMC Publication
- EN 61000-4-3:1996** - Electromagnetic compatibility (EMC) Part 4: Testing and  
measurement techniques, Section 3: Radiated, radio-  
Frequency, electromagnetic field immunity test
- EN 61000-4-4:1995** - Electromagnetic compatibility (EMC) Part 4: Testing and  
measurement techniques, Section 4: Electrical fast transient  
/ Burst immunity test Basic EMC publication
- EN 61000-4-5: 1995** - Electromagnetic compatibility (EMC) Part 4: Testing and  
measurement techniques, Section 5: Surge immunity test  
(includes corrigendum: 1995)
- EN 50141:1993** - Electromagnetic compatibility –Basic immunity  
standard–Conducted disturbances induced by  
radio-frequency fields–Immunity test
- EN 61000-4-11: 1994** - Electromagnetic compatibility (EMC) Part 4: Testing and  
measurement techniques, Section 11: Voltage dips, short  
interruptions and voltage variations immunity tests

## 2. Product Information

- a. **EUT Type :** PHOTOELECTRIC BEAM SENSOR
- b. **Model :** PB-80HD
- c. **Chipset Type :** N/A
- d. **System speed :** N/A
- e. **Crystal/Oscillator(s) :** N/A
- f. **Port/connector(s) :** N/A
- g. **Memory Expansion :** N/A
- h. **Power Rating :** DC 12V ----From DC Power Supplier
- i. **Chassis Used :** ABS
- j. **Condition of the EUT :** Prototype Sample  Engineering Sample  
Production Sample
- k. **Test Item Receipt Date :** MAR. / 28 / 2002

### 3. EUT Description

The equipment under test (EUT) is PHOTOELECTRIC BEAM SENSOR model PB-80HD, PB-60HD and PB-30HD. These models have identical electrical design and construction except their maximum beam ranges are different (PB-80HD: outdoor 80M, PB-60HD: outdoor 60M, PB-30HD: outdoor 30M). After verifying these models, we only took the worst-case model PB-80HD for test. The EUT consists of one transmitter and one receiver. Power provided to EUT is DC 12V from DC Power Supplier. For more detail specification about EUT, please refer to the user's manual.

Test method: The EUT powered by DC power source was placed on turntable for test. Test engineer tried to obtain the worst-case test data by placing obstruction between transmitter and receiver to trigger off operating during the test. The worst-case test result was recorded and provided in this report.

As pre-scan, we took radiated emission first. EUT configuration including peripheral devices placement and data cables coupling was compliant with EN55022 requirement. Test engineer tried to find the worst data cables coupling in order to perform the final test that radiated emission would keep the same configuration under test.

Conducted emission test:  
N/A

Radiated emission test:

The maximum readings were found by varying the height of antenna and then rotating the turntable. Both polarization of antenna, horizontal and vertical, are measured. The effect of varying the position of the interface cables has been investigated to find the configuration that produces maximum emission.

The highest emissions were also analyzed in details by operating the spectrum analyzer in fixed tuned quasi-peak mode to determine the precise amplitude of the emissions. While doing so, the antenna height was varied between one and four meters, and the turntable was slowly rotated, to maximize the emission.

#### **4. Modification(s):**

N/A

#### **5. Test Software Used**

N/A

## 6. Support Equipment Used

**1.DC1**

**FCC ID : N/A**

**Manufacturer : MEEILEHLIH**

**Model Number : TH-1225A**

**Power Supply : Linear**

**Power Cord : N/A**

**Data Cable : N/A**

## 7. EN 55022 Conducted Disturbance Test

Test Standard	Model No.	Result
EN 55022:1998	PB-80HD	N/A

Note:

- (a) In technical view, this product cannot generate disturbances above the limit  
As defined in the standard, so we didn't do the test.

## 8. EN 55022 Radiated Disturbance Test

Test Standard	Model No.	Result
EN 55022	PB-80HD	Passed

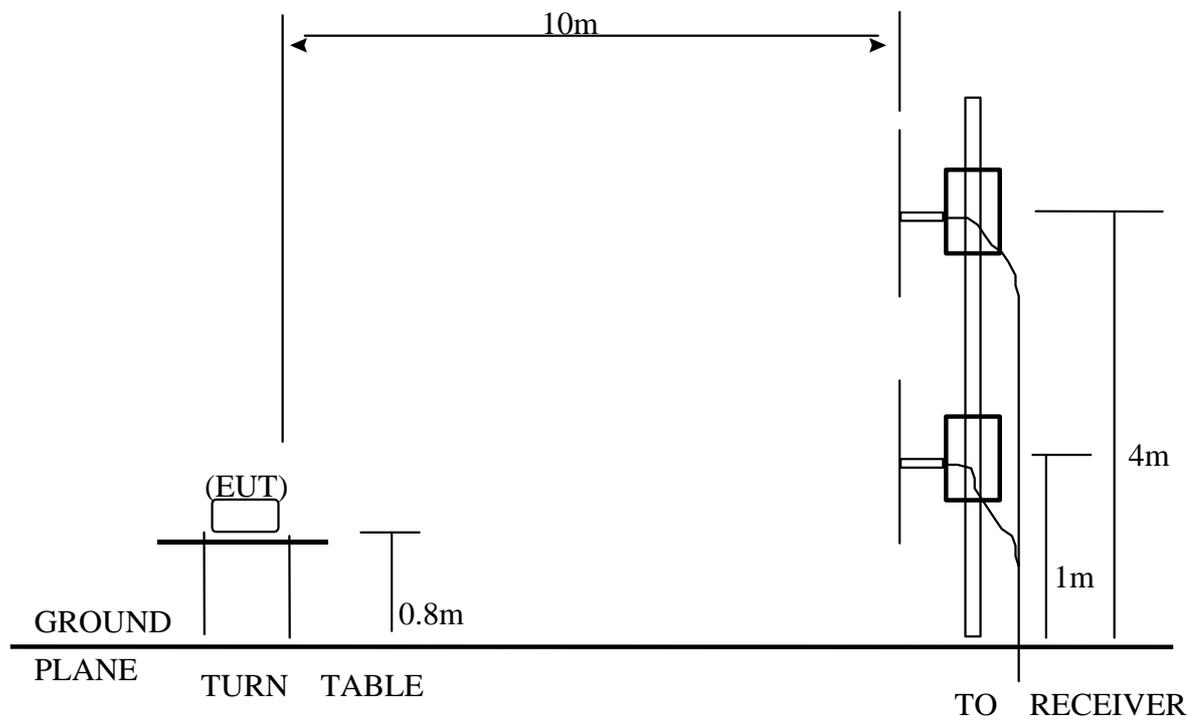
### 8.1 Radiated Disturbance Test Description

Preliminary measurements were made indoors chamber at 3 meter using broadband antennas, broadband amplifier, and spectrum analyzer to determine the frequency producing the maximum EME. Appropriate precaution was taken to ensure that all EME from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, turntable azimuth with respect to the antenna were noted for each frequency found. The spectrum was scanned from 30 to 1000 MHz using logbicon antenna. Above 1GHz, linearly polarized double ridge horn antenna were used.

Final measurements were made outdoors at 10-meter test range using biconical, dipole antenna or horn antenna. The test equipment was placed on a wooden bench situated on a 1.5x1 meter area adjacent to the measurement area. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. Each frequency found during pre-scan measurements was re-examined and investigated using Quasi-Peak Adapter. The detector function was set to CISPR quasi-peak mode and the bandwidth of the receiver was set to 120kHz.

The half-wave dipole antenna was tuned to the frequency found during preliminary radiated measurements. The EUT, support equipment and interconnecting cables were re-configured to the set-up producing the maximum emission for the frequency and were placed on top of a 0.8-meter high non-metallic 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were re-arranged and manipulated to maximize each EME emission. The turntable containing the system was rotated; the antenna height was varied 1 to 4 meters and stopped at the azimuth or height producing the maximum emission.

## 8.2 Radiated Disturbance Test Setup



EUT = Equipment Under Test

### 8.3 Radiated Disturbance Test Limits

Limits for radiated disturbance of Class A ITE at  
a measuring distance of 10 m

Frequency MHz	Field Strength dB( $\mu$ V/m)
30 to 230	40
230 to 1 000	47
<p>NOTES</p> <p>1 The lower limit shall apply at the transition frequency.</p> <p>2 Additional provisions may be required for cases where interference occurs.</p>	

Limits for radiated disturbance of Class B ITE at  
a measuring distance of 10 m

Frequency MHz	Field Strength dB( $\mu$ V/m)
30 to 230	30
230 to 1 000	37
<p>NOTES</p> <p>1 The lower limit shall apply at the transition frequency.</p> <p>2 Additional provisions may be required for cases where interference occurs.</p>	

### 8.4 Radiated Disturbance Test Setup Photo.

< FRONT VIEW >



< REAR VIEW >



## 8.5 Radiated Disturbance Test Data

**Model No.** : PB-80HD  
**Frequency range** : 30MHz to 1GHz     **Detector** : Quasi-Peak Value  
**Frequency range** : above 1GHz         **Detector** : Quasi-Peak/Average Value  
**Temperature** : 23° C                     **Humidity** : 55 %

**Antenna polarization** : HORIZONTAL ; **Test distance** : 10m ;

Freq. (MHz)	Level (dBuV/m)	Over Limit (dB)	Limit Line (dBuV/m)	Read Level (dBuV)	Antenna Factor (dB)	Cable Loss (dB)	Preamp Factor (dB)	Azimuth (° angle)	Antenna High(m)
74.745	14.14	-15.86	30.00	27.98	6.07	0.10	20.01	255.0	4.0
119.829	14.61	-15.39	30.00	22.22	12.09	0.30	20.00	253.0	4.0
127.921	14.67	-15.33	30.00	23.00	11.22	0.30	19.85	258.0	4.0
173.836	13.84	-16.16	30.00	24.23	8.86	0.60	19.85	251.0	4.0
239.904	16.48	-20.52	37.00	23.53	11.33	1.02	19.40	252.0	4.0
450.199	22.91	-14.09	37.00	25.13	16.40	1.76	20.38	256.0	3.8

Note :

1. Level = Read Level + Antenna Factor + Cable Loss – Preamp Factor
2. Over Limit = Level – Limit Line

**Model No. : PB-80HD**  
**Frequency range : 30MHz to 1GHz**     **Detector : Quasi-Peak Value**  
**Frequency range : above 1GHz**     **Detector : Quasi-Peak/Average Value**  
**Temperature : 23° C**     **Humidity : 55 %**

**Antenna polarization : VERTICAL ; Test distance : 10m ;**

Freq. (MHz)	Level (dBuV/m)	Over Limit (dB)	Limit Line (dBuV/m)	Read Level (dBuV)	Antenna Factor (dB)	Cable Loss (dB)	Preamp Factor (dB)	Azimuth ( angle)	Antenna High(m)
31.632	17.03	-12.97	30.00	19.39	17.47	0.10	19.93	259.0	1.0
120.413	16.87	-13.13	30.00	24.46	12.04	0.30	19.93	250.0	1.0
127.340	16.78	-13.22	30.00	25.00	11.28	0.30	19.80	251.0	1.0
172.055	13.80	-16.20	30.00	24.03	8.96	0.60	19.79	254.0	1.0
230.256	13.12	-23.88	37.00	22.02	9.96	0.94	19.80	253.0	1.0
449.445	21.91	-15.09	37.00	24.13	16.41	1.76	20.39	254.0	1.1

Note :

1. Level = Read Level + Antenna Factor + Cable Loss – Preamp Factor
2. Over Limit = Level – Limit Line

## 9. EN 61000-4-2 Electrostatic Discharge Test

Test standard	Model No.	Result
EN 61000-4-2	PB-80HD	Passed

**Criteria for Compliance:**

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs.

## 9.1 Electrostatic Discharge Test Description

This standard relates to equipment, systems, sub-systems and peripherals which may be involved in static electricity discharges owing to environmental and installation conditions. such as low relative humidity, use of low-conductivity (artificial-fibre) carpets, vinyl garments, etc., which may exist in allocations classified in standards relevant to electrical and electronic equipment.

The test set-up shall consist of a wooden table, 0.8 m high standing on the ground reference plane. A horizontal coupling plane(HCP), 1.6 m x 0.8 m, shall be placed on the table. The EUT and cables shall be isolated from the coupling plane by an insulating support 0.5 mm thick .

A ground reference plane shall be provided on floor of the laboratory. It shall be metallic sheet of 0.25 mm minimum thickness. The minimum size of the reference plane is 1 m, the exact size depending on the dimensions of the EUT .

It shall project beyond the EUT or coupling plane by at least 0.5 m on all sides. and shall be connected to the protective grounding system.

In order to minimize the impact of environmental parameters on test results, the tests shall be carried out in climatic and electromagnetic reference conditions.

### Climatic conditions

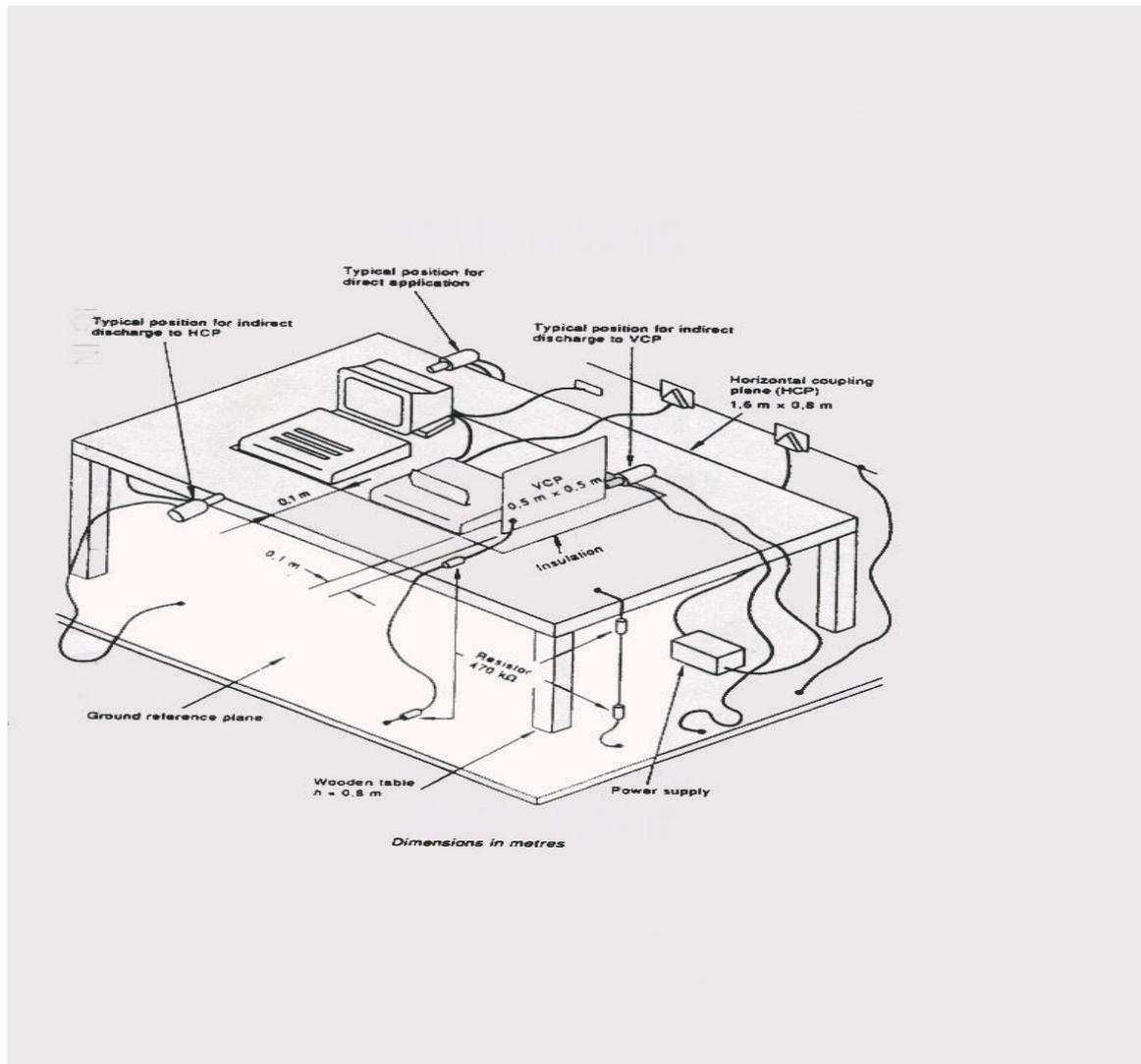
- ambient temperature: 15 to 35 ;
- relative humidity: 30 % to 60%
- atmospheric pressure: 86 KPa (860 mbar) to 106 KPa (1 060 mbar).

NOTE – Any other values are specified in the product specification.

### Electromagnetic conditions

The electromagnetic environment of the laboratory shall not influence the test results.

## 9.2 Electrostatic Discharge Test Setup

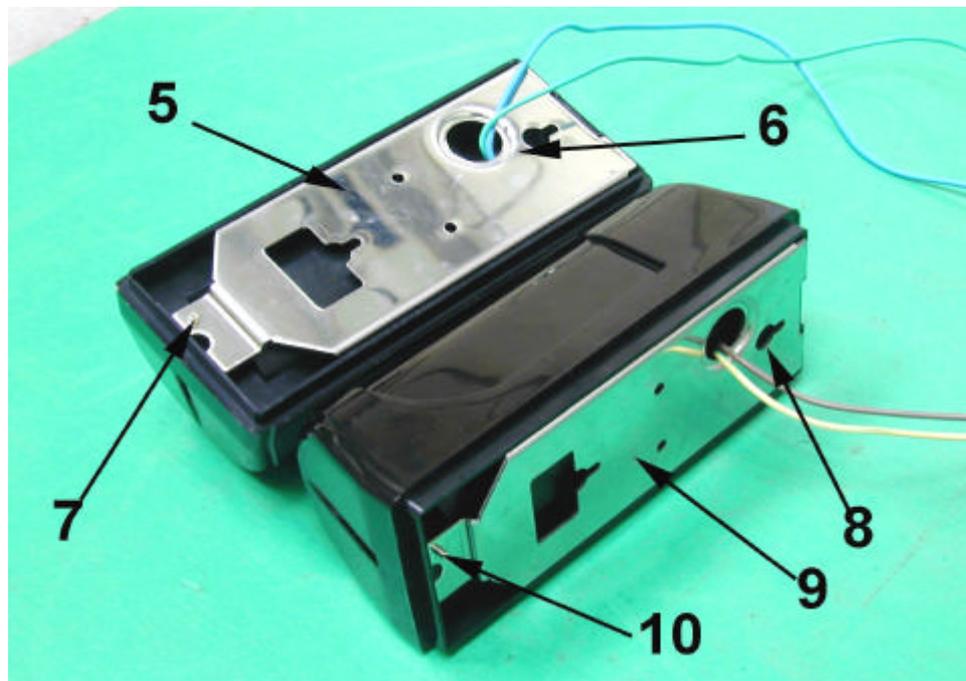


- Example of test set-up for table-top equipment,  
laboratory tests

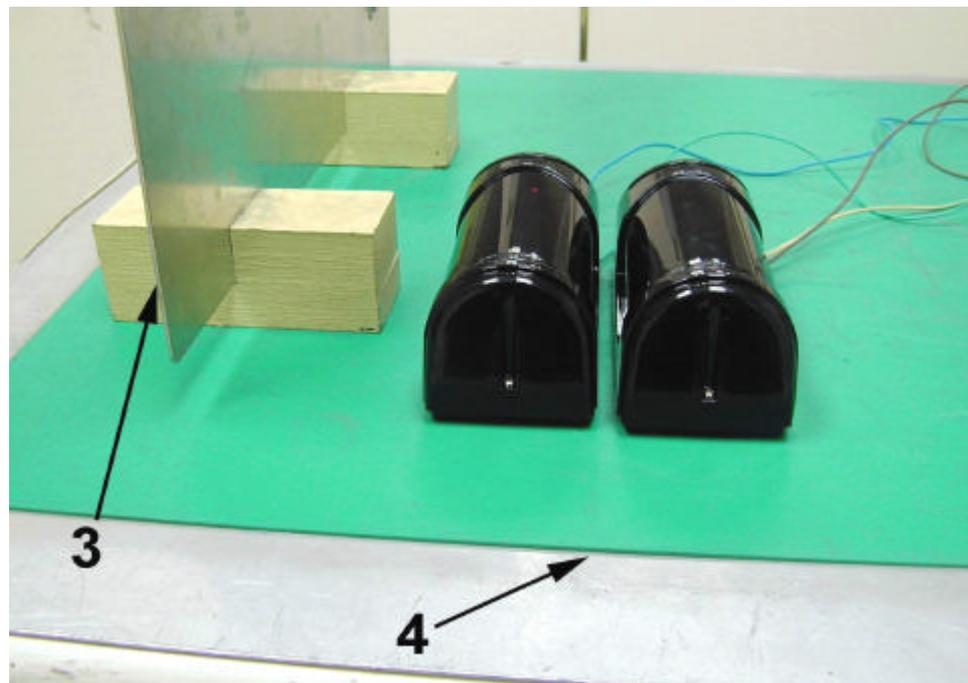
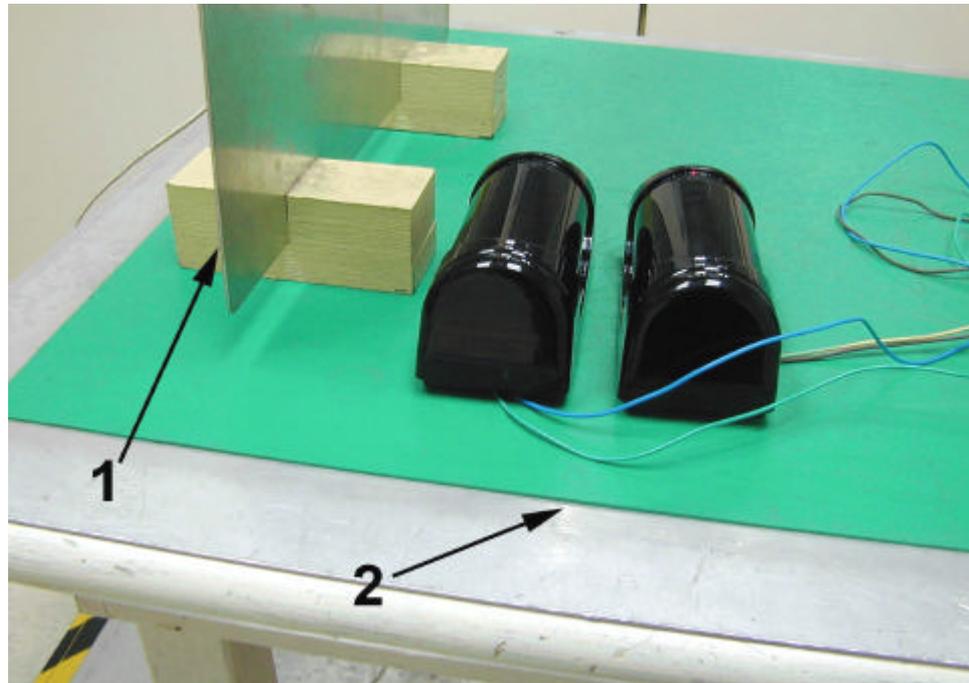
### 9.3 Electrostatic Discharge Test Limits

Test voltages <sup>1)</sup> :		
Air discharges	(kV)	2; 4 & 8
Contact discharges	(kV)	2; 4 & 6
Polarity		+ & -
Number of discharges per point for each voltage and polarity		10
Interval between discharges	(s)	= 1
<p><sup>1)</sup>The test voltages specified are the open-circuit voltages.</p> <p>The test voltages for the lower severity levels are included because all the lower severity levels must also be satisfied.</p>		

### 9.4 Direct Discharge Test Drawing



## Indirect Discharge Test Drawing







## 10. EN 61000-4-3 Radio-Frequency Electromagnetic Field Test

Test standard	Model No.	Result
EN 61000-4-3	PB-80HD	Passed

Field Strength : 10 V/M ,

Modulation : AM 80 % , 1KHz . ON (YES) . OFF (\_\_\_)

Start : 80 MHz , Stop : 1000 MHz . DC Power : 12 Vac

Pulse modulation: 1 Hz ON (YES) . OFF (\_\_\_)

Start : 80 MHz , Stop : 1000 MHz . DC Power : 12 Vac

### Criteria for Compliance:

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs.

## 10.1 Radio-Frequency Electromagnetic Field Test Description

Most electronic equipment is, in some manner, affected by electromagnetic radiation.

This radiation is frequently generated by such sources as the small hand-held radio transceivers that are used by operating, maintenance and security personnel, fixed-station radio and television transmitters, vehicle radio transmitters, and various industrial electromagnetic sources.

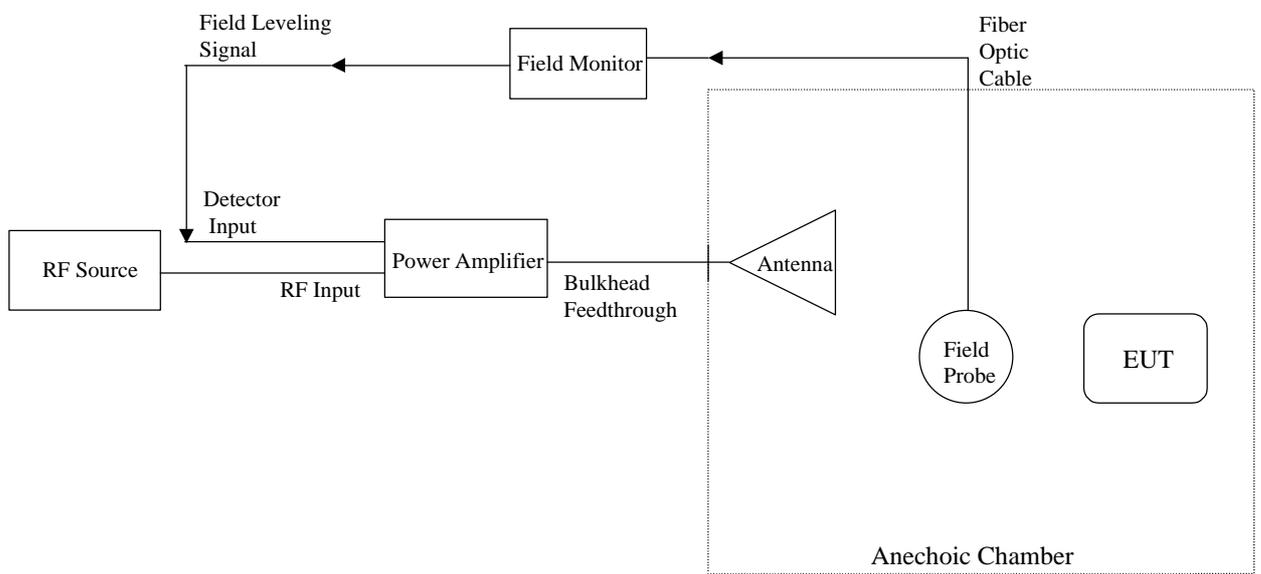
In addition to electromagnetic energy deliberately generated, there is also spurious radiation caused by devices such as welders, thyristors, fluorescent lights, switches operating inductive loads, etc. For the most part, this interference manifests itself as conducted electrical interference and, as such, is dealt with in other parts of this standard. Methods employed to prevent effects from electromagnetic fields will normally also reduce the effects from these sources.

The electromagnetic environment is determined by the strength of the electromagnetic field (field strength in volts per metre). The field strength is not easily measured without sophisticated instrumentation nor is it easily calculated by classical equations and formulae because of the effect of surrounding structures or the proximity of other equipment that will distort and/or reflect the electromagnetic waves.

All testing of equipment shall be performed in a configuration as close as possible to the installed case. Wiring shall be consistent with the manufacturer's recommended procedures, and the equipment shall be in its housing with all covers and access panels in place, unless otherwise stated.

If the equipment is designed to be mounted in a panel, rack or cabinet, it shall be tested in this configuration.

## 10.2 Radio-Frequency Electromagnetic Field Test Block Diagram



### 10.3 Radio-Frequency Electromagnetic Field Test Limits

Frequency range	(MHz)	80 to 1000
Field strength <sup>1)</sup>	(V/m)	10
Modulation:		
Amplitude modulation		80%, 1 kHz, sinusoidal
Pulse modulation		1 Hz (0.5 s ON: 0.5 s OFF)
<sup>1)</sup> The field strength quoted is the RMS value for the continuous wave, before modulation.		

## 10.4 Radio-Frequency Electromagnetic Field Test Setup Photos

< FRONT VIEW >



## 11. EN 61000-4-4 Fast Transient Burst Test

Test standard	Model No.	Result
EN 61000-4-4	PB-80HD	Passed

### Criteria for Compliance:

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the bursts is permissible, providing that there is no residual change in the EUT or any change in outputs.

## 11.1 Fast Transient Bursts Test Description

The repetitive fast transient test is a test with bursts consisting of a number of fast transients, coupled into power supply, control and signal ports of electrical and electronic equipment. Significant for the test are the short rise time, the repetition rate and the low energy of the transients.

The test shall be carried out on the basis of a test plan including verification of the performances of the EUT as defined in the technical specification.

### Climatic conditions

The tests shall be carried out in standard climatic conditions in accordance with IEC 68-1:

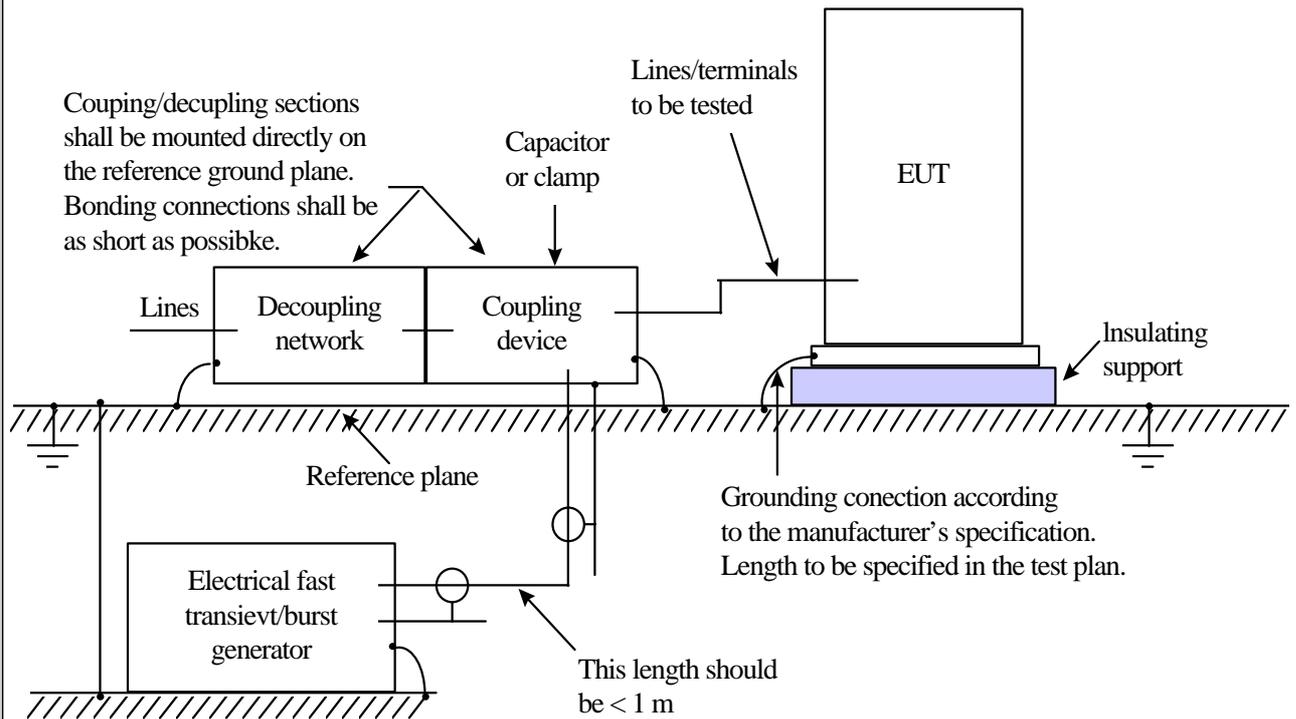
- ambient temperature: 15 to 35
- relative humidity: 25% to 75%
- atmospheric pressure: 86kPa (860 mbar) to 106Kpa (1 060 mbar)

NOTE – Any other values are specified in the product specification.

### Electromagnetic conditions

The electromagnetic conditions of the laboratory shall be such to guarantee the correct operation of the EUT in order not to influence the test results.

## 11.2 Fast Transient Burst Test Setup



Block-diagram for electrical fast transient/burst immunity test

### 11.3 Fast Transient Burst Test Limits

Test voltages: <sup>1)</sup>		0.5; 1 & 2
a. c. mains supply lines	(kV)	
other supply/signal lines	(kV)	0.25; 0.5 & 1
Polarity		+ & -
Number of applications for each voltage and polarity		1
Duration per application	(min)	1 <sup>+0.2</sup> <sub>-0</sub>
<p><sup>1)</sup> The test voltages specified are the open-circuit voltages. The test voltages for the lower severity levels are included because all the lower severity levels must also be satisfied.</p>		

## 11.4 Fast Transient Burst Test Setup Photos

< FRONT VIEW >





## 12. EN 61000-4-5 Surge Immunity Test

Test standard	Model No.	Result
EN 61000-4-5	PB-80HD	Passed

### Criteria for Compliance:

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the surge is permissible, providing that there is no residual change in the EUT or any change in outputs.

## 12.1 Surge Immunity Test Description

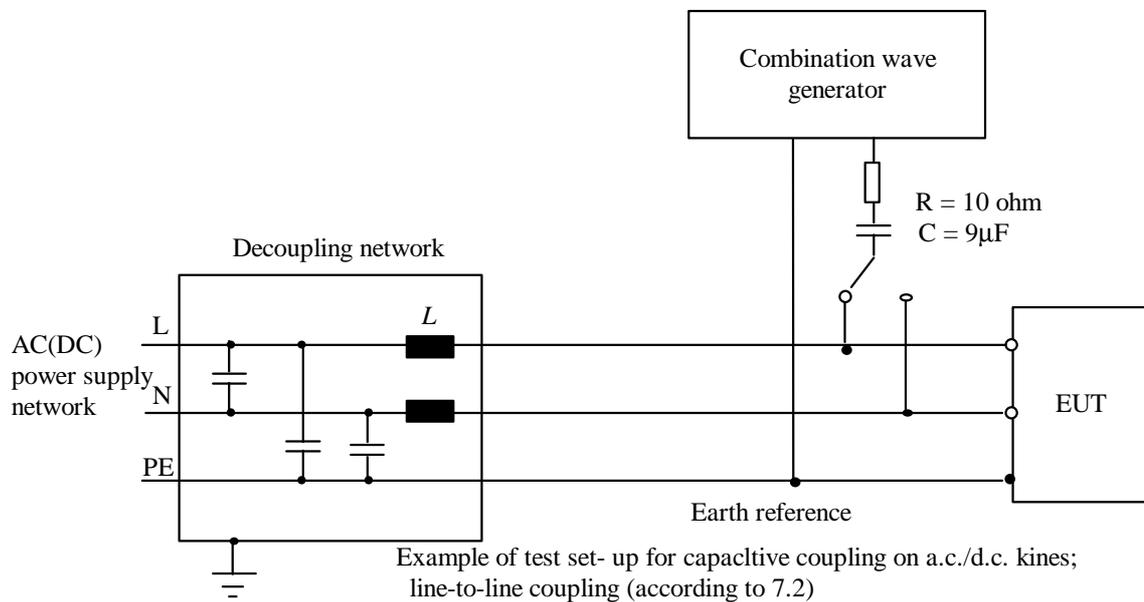
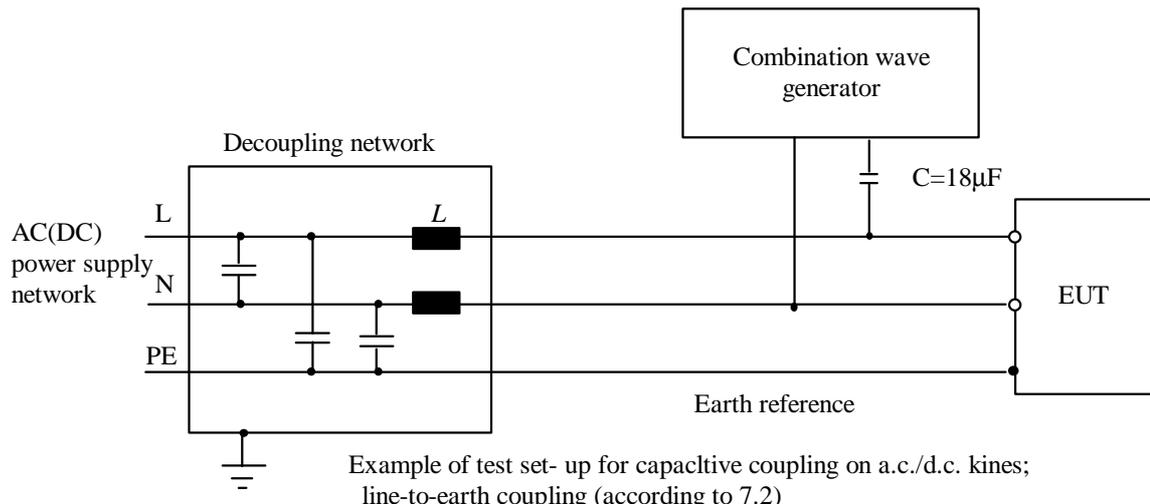
The task of the described laboratory test is to find the reaction of the EUT under specified operational conditions caused by surge voltages from switching and lightning effects at certain threat levels.

The following equipment is part of the test set-up :

- equipment under test (EUT);
- auxiliary equipment (AE);
- cables (of specified type and length);
- coupling device (capacitive or arrestors);
- test generator (combination wave generator, 1.2/50  $\mu$ s generator);
- decoupling network/protection devices;
- additional resistors, 10 ohm and 40 ohm

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines and to provide sufficient decoupling impedance to the surge wave so that the specified wave may be developed on the lines under test .

## 12.2 Surge Immunity Test Setup



### 12.3 Surge Immunity Test Limits

Test voltages <sup>1)</sup> :	
a. c. mains supply lines:	
- line-to-line (kV)	0.5 & 1
- line-to-ground <sup>2)</sup> (kV)	0.5; 1 & 2
other supply/signal lines:	
- line-to-ground <sup>3)</sup> (kV)	0.5 & 1
Polarity	+ & -
Minimum number of surges at each polarity, voltage, coupling mode and line:	
- a. c. mains supply lines	20 <sup>4)</sup>
- other supply/signal lines	5
<p><sup>1)</sup> The test voltages specified are the open-circuit voltages. The test voltages for the lower severity levels are included, because all the lower severity levels must also be satisfied.</p> <p><sup>2)</sup> via a 10 Ω series resistor.</p> <p><sup>3)</sup> via a 10 Ω series resistor.</p> <p><sup>4)</sup> 5 at each zero-crossing point and at the maximum and minimum points on the mains voltage wave.</p>	

## 12.4 Surge Immunity Test Setup Photos

< FRONT VIEW >





### 13. The List of Test Instruments

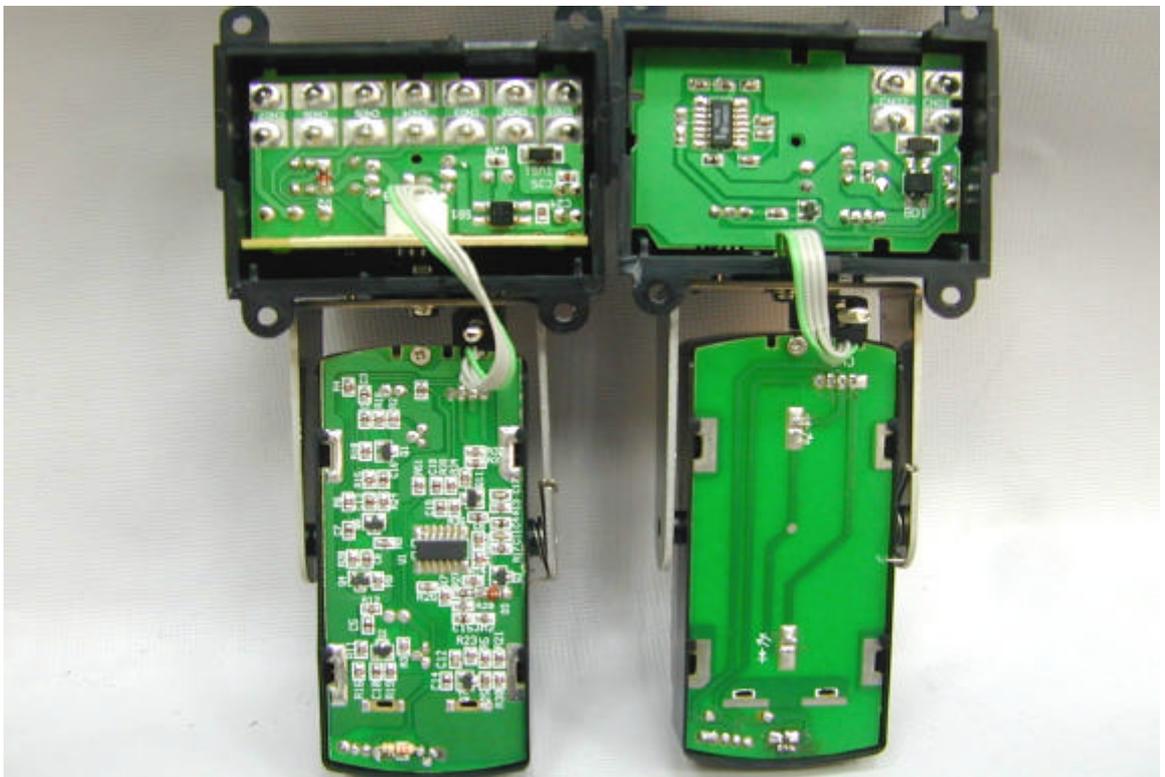
Test Mode	Instrument	Model No.	Serial No.	Next Cal. Date	Cal. Interval	Measurement Uncertainty
<b>Conduction (No.1)</b>	R & S Receiver	ESHS10	830223/008	Nov. 14, 2001	1Year	
	Rolf Heine LISN	NNB-4/63TL	98008	NO NEED (2nd LISN)	1Year	
	R & S LISN	ESH3-Z5	844982/039	Jul. 25, 2002	1Year	
	Spectrum Analyzer	R3261A	91720076	May 03, 2002	1Year	
	RF Cable	Rg400	N/A	Jul. 08, 2002	1Year	
	Schaffner ISN	T411	N/A	Jul. 01, 2002	1Year	
<b>Radiation (OP No.1)</b>	R & S Receiver	ESVS30	863342/012	May 07,2002	1Year	
	Anritsu Pre-Amp.	MH648A	M15080	Apr. 10, 2003	1Year	
	R & S Pre-Amp.	ESMI-Z7	612278/011	Aug. 02, 2002	1Year	
	Schaffner Antenna	CBL6112B (30MHz~2GHz)	2655	Jul. 27, 2002	1Year	
	COM-Power Horn Ant.	AH-118 (1GHz~18GHz)	10095	Jul. 25, 2002	1Year	
	EMCO RF Cable	175series	NO. 1	Apr. 10, 2003	1Year	
	Schwarzbeck Precision Dipole Ant	VHAP (30MHz~1GHz)	970 + 971 953 + 954	Jun. 27, 2003	3Year	
	R &S Signal Generator	SMY01	841104/037	Aug. 26, 2002	1Year	
	RF Cable	No. 1	N/A	Jul. 26, 2002	1Year	
	EMCO Antenna	3142B (26MHz~2GHz)	9904-1307	Jul. 01, 2002	1Year	

Test Mode	Test item	Instrument	Model No.	Serial No.	Next Cal. Date	Cal. Interval	Measurement Uncertainty
<b>EMS (NO.1)</b>	4-2	ESD Test System	ESS-100L (A)TC-815D	4099C01970	July 17, 2002	1Year	
	4-3	Comtest G-Strip	G-320	CC112-0008	Oct. 01, 2002	2Year	
	4-4	KeyTek EFT Noise Generator	CE-40	9508266	Dec. 14, 2002	2Year	
	4-5	HAEFELY Surge Tester	PSURGE 4	083665-17	Nov. 24, 2002	2Year	
	4-11	HAEFELY Line Interference Tester	PLINE 1610	083732-01	Nov. 26, 2002	2Year	
	4-3	HP Signal Generator	8648A	3619U00426	Sep. 15, 2002	1Year	
	3-2 3-3	HP Harmonic/ Flicker Test System	6842A	3531A-00141	Nov. 26, 2002	2Year	

## 14. EUT Photographs

MODEL NO. : PB-80HD;





# VERIFICATION

## of conformity with European EMC Directive

No. E910239

*Document holder:* YUAN HSUN ELECTRIC CO., LTD.  
*Type of equipment:* PHOTOELECTRIC BEAM SENSOR  
*Type designation:* PB-80HD, PB-60HD, PB-30HD

EMC sample of the equipment has been tested for CE-marking according to the Directive, 89/336/EEC.

*Standard(s) used for showing compliance with the essential requirements of the directive:*

<i>Standard(s):</i>	<i>Performance Criterion</i>
EN 55022 :1998	Class B
EN 61000-3-2:1995 + A1:1998 + A2:1998	
EN 61000-3-3:1995	
EN 50130-4 :1995 + A1:1998	
EN 61000-4-2: 1995 + A1:1998	
EN 61000-4-3: 1996	
EN 61000-4-4: 1995	
EN 61000-4-5: 1995	
ENV 50141: 1993	
EN 61000-4-11: 1994	
Main Supply Voltage Variations	

The referred test report(s) show that the product fulfills the requirements in the EMC Directive for CE marking. On this basis, together with the manufacturer's own documented production control, the manufacturer (or his European authorized representative) can in his EC Declaration of Conformity verify compliance with the EMC Directive.

**Signed for and on behalf of  
PEP Testing Laboratory**



*M. Y. Tsui*

**Date: APR. 09, 2002**

**M. Y. Tsui / President**

# Declaration of Conformity

The following

**Applicant** : YUAN HSUN ELECTRIC CO., LTD.

**Equipment** : PHOTOELECTRIC BEAM SENSOR

**Model No.** : PB-80HD, PB-60HD, PB-30HD

**Report No.** : E910239

is herewith confirmed to comply with the requirements set out in the Council Directive on the Approximation of the Laws of the Member States relating to Electromagnetic Compatibility(89/336/EEC) and the amendments in the Council Directive 92/31/EEC, 93/68/EEC.

For the evaluation of above mentioned Directives, the following standards were applied:

- 1) EN 55022: 1998 Class B
- 2) EN 61000-3-2 : 1995+A1:1998+A2:1998
- 3) EN 61000-3-3 : 1995
- 4) EN 50130-4:1995 +A1:1998 EN 61000-4-2 :1995+A1:1998  
EN 61000-4-3 :1996  
EN 61000-4-4 :1995  
EN 61000-4-5 :1995  
ENV 50141 :1993  
EN 61000-4-11 : 1994

Main Supply Voltage Variations

The following manufacturer is responsible for this declaration:

YUAN HSUN ELECTRIC CO., LTD.

NO. 57, CHUNG-HE RD., KAOHSIUNG CITY,  
TAIWAN, R. O. C.

TAIWAN / APR. 09, 2002

Place and Date

\_\_\_\_\_  
Signature of responsible Person

